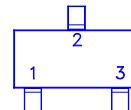
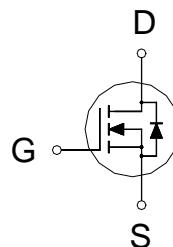


NIKO-SEM
**N-Channel Enhancement Mode
Field Effect Transistor**
P3202CMG
SOT-23
Halogen-Free & Lead-Free
PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
20	32mΩ	5A


1. GATE
2. DRAIN
3. SOURCE
ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Gate-Source Voltage		V_{GS}	± 12	V
Continuous Drain Current	$T_A = 25^\circ\text{C}$	I_D	5	A
	$T_A = 70^\circ\text{C}$		4	
Pulsed Drain Current ¹		I_{DM}	30	
Power Dissipation	$T_A = 25^\circ\text{C}$	P_D	1.25	W
	$T_A = 70^\circ\text{C}$		0.8	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	°C
Lead Temperature (1/16" from case for 10 sec.)		T_L	275	

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient	$R_{\theta JA}$	75	100	°C/W

¹Pulse width limited by maximum junction temperature.
ELECTRICAL CHARACTERISTICS ($T_c = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	20			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	0.45	0.75	1.2	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 12V$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 16V, V_{GS} = 0V$			1	μA
		$V_{DS} = 16V, V_{GS} = 0V, T_J = 70^\circ\text{C}$			10	
On-State Drain Current ¹	$I_{D(\text{ON})}$	$V_{DS} = 10V, V_{GS} = 10V$	5			A
Drain-Source On-State Resistance ¹	$R_{DS(\text{ON})}$	$V_{GS} = 1.8V, I_D = 2A$		57	80	$\text{m}\Omega$
		$V_{GS} = 2.5V, I_D = 4A$		38	50	
		$V_{GS} = 4.5V, I_D = 5A$		27	32	

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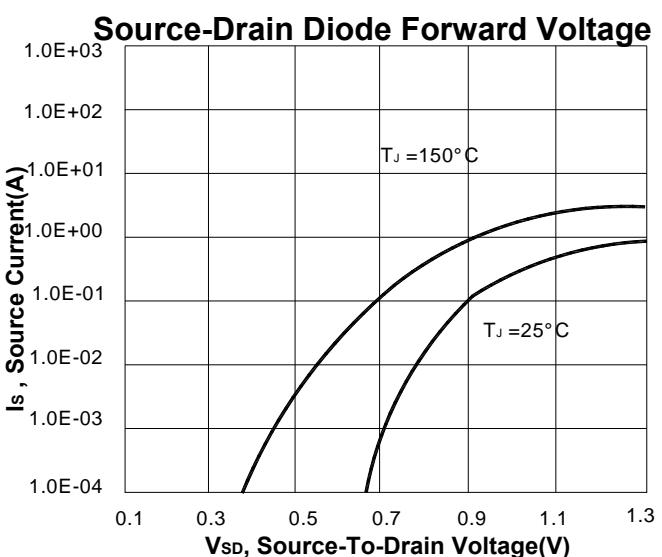
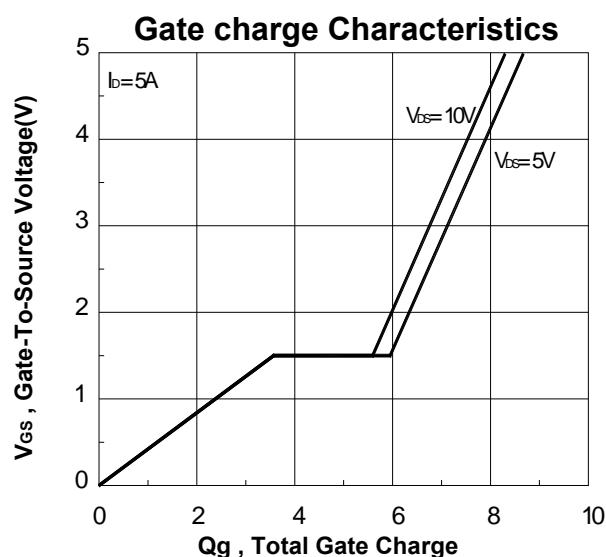
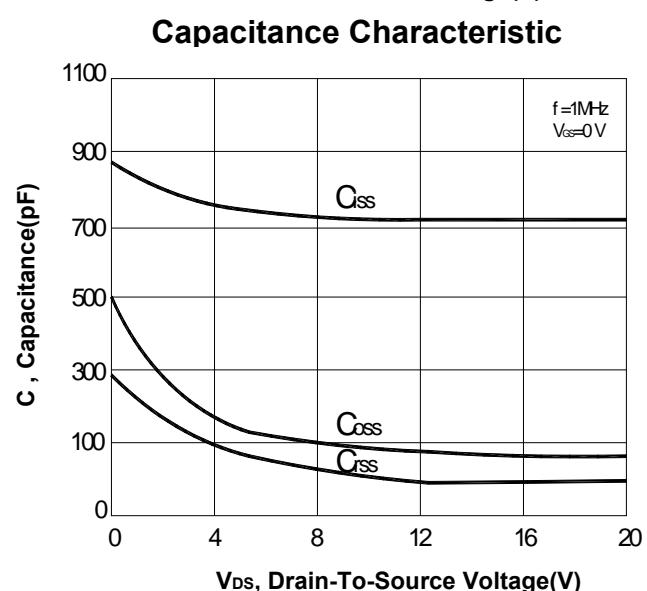
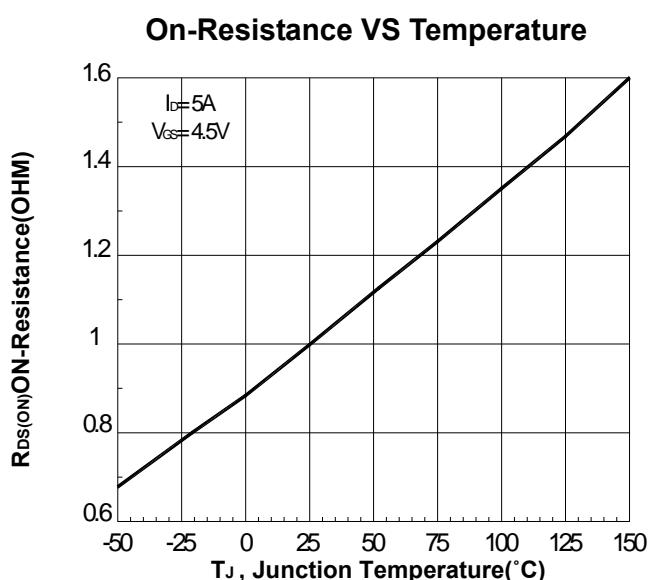
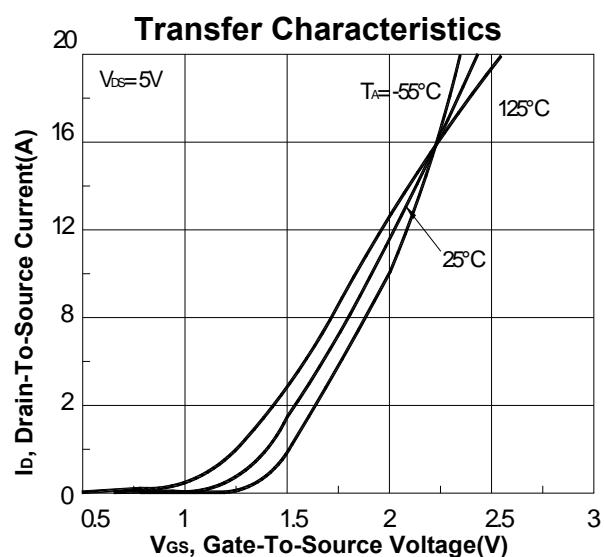
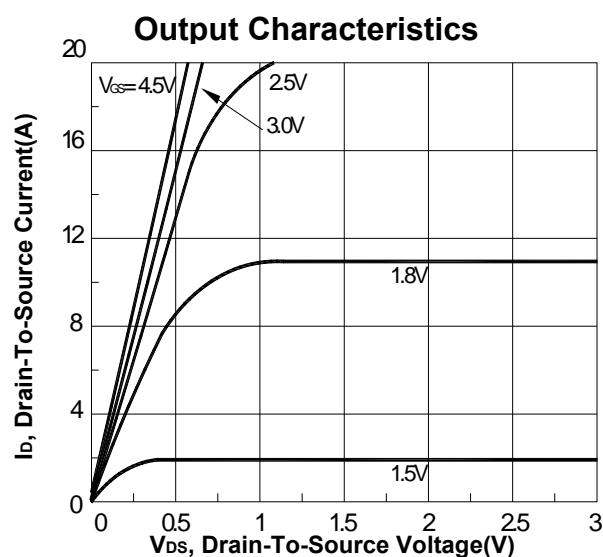
Forward Transconductance ¹	g_{fs}	$V_{DS} = 5V, I_D = 5A$		12		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 10V, f = 1MHz$		740		pF
Output Capacitance	C_{oss}			90		
Reverse Transfer Capacitance	C_{rss}			66		
Total Gate Charge ²	Q_g			8	12	
Gate-Source Charge ²	Q_{gs}	$V_{DS} = 0.5V_{(BR)DSS}, V_{GS} = 4.5V,$ $I_D = 5A$		3.6		nC
Gate-Drain Charge ²	Q_{gd}			2		
Turn-On Delay Time ²	$t_{d(on)}$			8	14	
Rise Time ²	t_r			6	12	
Turn-Off Delay Time ²	$t_{d(off)}$	$V_{DD} = 10V,$ $I_D \approx 1A, V_{GEN} = 4.5V, R_G = 0.2\Omega$		19	45	nS
Fall Time ²	t_f			7	23	
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_c = 25^\circ C$)						
Continuous Current	I_S				1	A
Forward Voltage ¹	V_{SD}	$I_F = I_S, V_{GS} = 0V$			1.3	V

¹Pulse test : Pulse Width $\leq 300 \mu sec$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.**REMARK: THE PRODUCT MARKED WITH “15YWW”, DATE CODE or LOT #**

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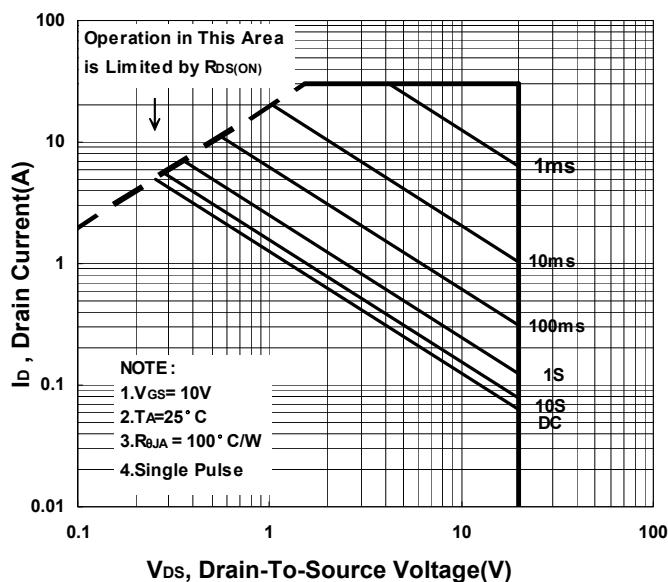


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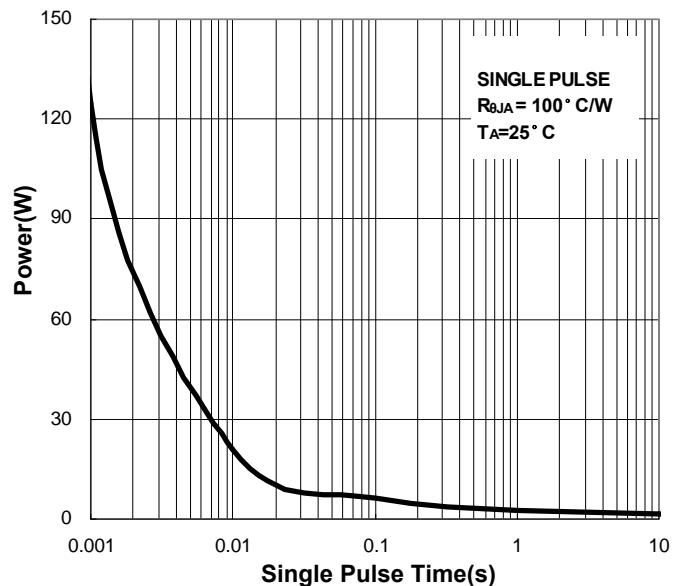
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Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

